QUALITY SEMICONDUCTOR, INC.

High-Speed CMOS 3.3V 18-Bit Registered Transceivers with Bus Hold

QS74LVCH16501A

ADVANCE INFORMATION

FEATURES/BENEFITS

- 5V tolerant inputs and outputs
- Bus Hold feature holds last active state during 3-state operation
- 10µA I_{CCQ} quiescent power supply current
- Hot insertable
- 2.0V–3.6V V_{CC} supply operation
- ±24mA balanced output drive
- Power down high impedance inputs and outputs
- t_{PD} = 4.6ns max.
- Input hysteresis for noise immunity
- Meets or exceeds JEDEC Standard 36 specifications
- Multiple power and ground pins for low noise
- Operating temperature range:
  –40°C to 85°C
- Latch-up performance exceeds 500mA
- ESD performance:
  Human body model > 2000V
  Machine model > 200V
- Packages available:
  56-pin TSSOP
  56-pin SSOP

DESCRIPTION

The LVCH16501A is an 18-bit registered bus transceiver with three-state outputs that are ideal for driving address and data buses. These high-speed, low-power registered transceivers combine D-type latches and D-type flip-flops to allow data flow in transparent, latched and clocked modes. The QS74LVCH16501A provides Bus Hold circuitry on the data inputs to retain the last active state during 3-state operation, eliminating the need for external pull-up resistors. The 3.3V LVC family features low power, low switching noise, and fast switching speeds for low power portable applications as well as high-end advanced workstation applications. 5V tolerant inputs and outputs allow this LVC product to be used in mixed 5V and 3.3V applications. Easy board layout is facilitated by the use of flow-through pinouts and byte enable controls provide architectural flexibility for systems designers. To accommodate hot-plug or live insertion applications, of this product is designed not to load an active bus when V_{CC} is removed. However, during power up or power down sequence, $\overline{OE}$ should be tied to V_{CC} to ensure high-impedance state on the outputs.

Figure 1. Functional Block Diagram

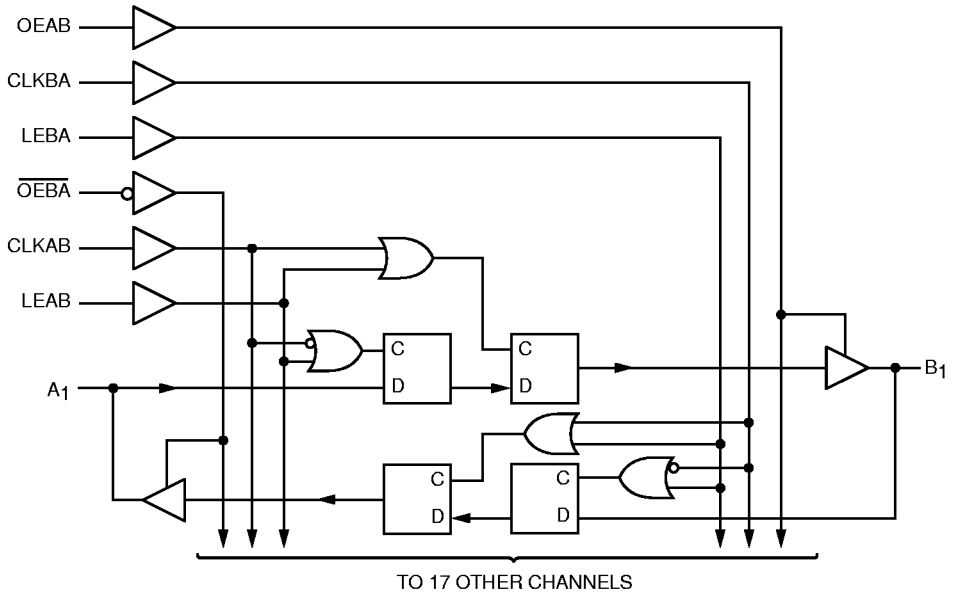


Figure 2. Pin Configuration
(All Pins Top View)

SSOP, TSSOP

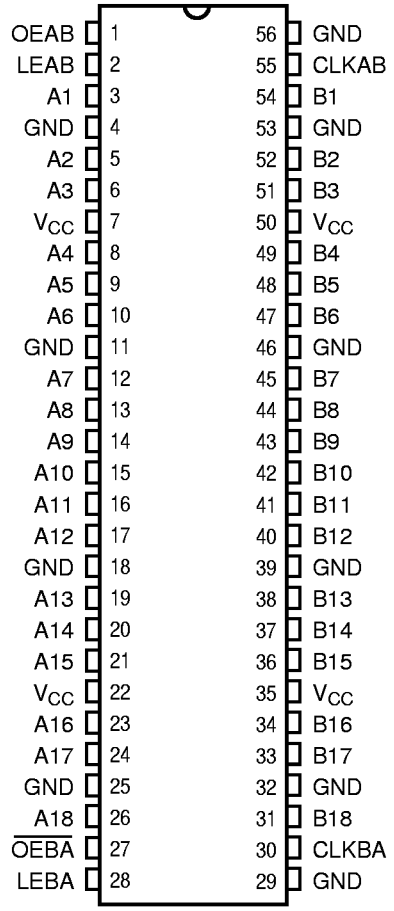


Table 1. Pin Description

Name	Description
OEAB	A-to-B Output Enable Input
$\overline{OEBA}$	B-to-A Output Enable Input (Active Low)
LEAB	A-to-B Latch Enable Input
LEBA	B-to-A Latch Enable Input
CLKAB	A-to-B Clock Input
CLKBA	B-to-A Clock Input
Ax	A-to-B Data Inputs or B-to-A 3-State Outputs
Bx	B-to-A Data Inputs or A-to-B 3-State Outputs

Table 2. Function Table (1)

Inputs				Outputs
OEAB	**LEAB**	**CLKAB**	**Ax**	**Bx**
L	X	X	X	Z
H	H	X	L	L
H	H	X	H	H
H	L	↑	L	L
H	L	↑	H	H
H	L	H	X	B(2)
H	L	L	X	B(3)

Notes:
1. A-to-B data flow is shown. B-to-A data flow is similar but uses $\overline{OEBA}$, LEBA, and CLKBA.
2. Output level before the indicated steady-state input conditions were established.
3. Output level before the indicated steady-state input conditions were established, provided that CLKAB was LOW before LEAB went LOW.

Table 3. Absolute Maximum Ratings

Supply Voltage to Ground	–0.5V to 7.0V
DC Output Voltage V_{OUT}	
Outputs HIGH-Z	–0.5V to 7.0V
Outputs Active	–0.5V to V_{CC} + 0.5V
DC Input Voltage V_{IN}	–0.5V to 7.0V
DC Input Diode Current with $V_{IN} < 0$	–50mA
DC Output Diode Current	
$V_O < 0$	–50mA
$V_O > V_{CC}$	50mA
DC Output Source/Sink Current (I_{OH}/I_{OL})	±50mA
DC Supply Current per Supply Pin	±100mA
DC Ground Current per Ground Pin	±100mA
T_{STG} Storage Temperature	–65°C to 150°C

Note: Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to this device resulting in functional or reliability type failures.

Table 4. Recommended Operating Conditions

Symbol	Parameter		Min	Max	Unit
V_{CC}	Supply Voltage, Operating		2.0	3.6	V
	Supply Voltage, Data Retention Only		1.5	3.6	
V_{IH}	Input HIGH Voltage	V_{OL} = 2.7 to 3.6V	2.0	—	V
V_{IL}	Input LOW Voltage	V_{CC} = 2.7 to 3.6V	—	0.8	V
V_{IN}	Input Voltage		0	5.5	V
V_{OUT}	Output Voltage in Active State		0	V_{CC}	V
	Output Voltage in "OFF" State		0	5.5	
I_{OH}	Output Current HIGH	V_{CC} = 3.0–3.6V	—	–24	mA
		V_{CC} = 2.7V		–12	
I_{OL}	Output Current LOW	V_{CC} = 3.0–3.6V	—	24	mA
		V_{CC} = 2.7V	—	12	
$\Delta t/\Delta v$	Input Transition Slew Rate		—	10	ns/V
T_A	Operating Free Air Temperature		–40	85	°C

Table 5. DC Electrical Characteristics Over Operating Range

Industrial Temperature Range, T_A = –40°C to 85°C

Symbol	Parameter	Test Conditions		Min	Typ(1)	Max	Unit
V_{OH}	Output HIGH Voltage	V_{CC} = 2.7V, I_{OH} = –100µA V_{CC} = 2.7V, I_{OH} = –12mA V_{CC} = 3.0V, I_{OH} = –12mA V_{CC} = 3.0V, I_{OH} = –24mA		V_{CC} –0.2 2.2 2.4 2.2	— — — —	— — — —	V
V_{OL}	Output LOW Voltage	V_{CC} = 2.7V, I_{OL} = 100µA V_{CC} = 2.7V, I_{OL} =12mA V_{CC} = 3.0V, I_{OL} = 24mA		— — —	— — —	0.2 0.4 0.55	V
V_{IK}	Input Clamp Voltage	V_{CC} = 2.7V, I_{IN} = –18mA		—	–0.7	–1.2	V
I_I	Input Leakage Current	V_I = 0V, V_I = 5.5V, V_{CC} = 3.6V		—	—	±1.0	µA
$\|I_{BH}\|$	Bus Hold Inputs Overdrive Current(2,3)	V_{CC} = 3.6V, V_{IN} =0V or V_{IN} = V_{CC}		—	—	50	µA
		V_{CC} = 3.6V, 0.8V < V_{IN} < 2.0V		—	—	500(4)	
I_{BHH} I_{BHL}	Bus Hold Input Sustaining Current	V_{CC} = 3V	V_{IN} = 2.0V	–75	—	—	µA
			V_{IN} = 0.8V	75	—	—	
I_{OZ}	High-Z I/O Leakage	V_O = 0V, V_O = 5.5V, V_I = V_{IH} or V_{IL}, V_{CC} = 3.6V		—	—	±1.0	µA
I_{OFF}	Power Off Leakage	V_{CC} = 0V, V_I or V_O = 5.5V		—	—	10	µA
I_{CC}	Quiescent Power Supply Current	V_{CC} = 3.6V, V_{IN} = V_{CC} or GND		—	0.1	10	µA
ΔI_{CC}	Quiescent Power Supply Current per Control Inputs at TTL HIGH	V_{CC} = 3.6V, V_{IN} = V_{CC} – 0.6V(5)		—	2.0	3.0	µA
	Quiescent Power Supply Current per Bus Hold Inputs at TTL HIGH	V_{CC} = 3.6V, V_{IN} = V_{CC} – 0.6V(5)		—	75	500	µA

Notes:
1. Typical values are at V_{CC} = 3.3V and T_A = 25°C.
2. These parameters are guaranteed by characterization, but not production tested.
3. Pins with Bus Hold are identified in the pin description.
4. An external driver must provide at least $|I_{BH}|$ during transition to guarantee that the Bus Hold input will change state.
5. Per TTL driven input. All other inputs at V_{CC} or GND.

Table 6. Dynamic Switching Characteristics

Symbol	Parameter	Test Conditions		Typ(1)	Unit
V_{OLP}	Quiet Output Dynamic Peak V_{OL}	C_L = 50pF, V_{CC} = 3.3V	V_{IH} = 3.3V, V_{IL} = 0V	0.8	V
V_{OLV}	Quiet Output Dynamic Valley V_{OL}	C_L = 50pF, V_{CC} = 3.3V	V_{IH} = 3.3V, V_{IL} = 0V	0.8	V
C_{PD}	Power Dissipation	C_L = 50pF, f = 10MHz,	Output Enable	35	pF
		V_{CC} = 3.3 ±0.3V	Output Disable	6	

Note:
1. Typical values are at V_{CC} = 3.3V, 25°C ambient.

Table 7. Capacitance(1)

Symbol	Pins	Conditions	Typ	Unit
C_{IN}	Input Capacitance	V_{IN} = 0V, V_{OUT} = 0V, f = 1MHz	7.0	pF
$C_{I/O}$	I/O Capacitance	V_{IN} = 0V, V_{OUT} = 0V, f = 1MHz	8.0	pF

Note:
1. Capacitance is characterized but not production tested.

Table 8. Switching Characteristics Over Operating Range

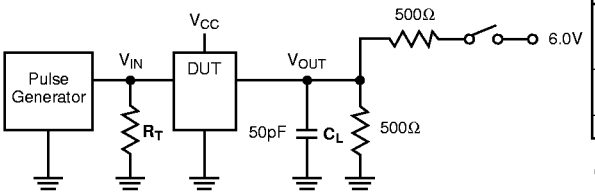
Industrial Temperature Range, T_A = –40°C to 85°C
C_{LOAD} = 50pF, R_{LOAD} = 500Ω unless otherwise noted.

Symbol	Description(1)		V_{CC} = 3.3 ±0.3V		V_{CC} = 2.7V(2)		Unit
			Min	Max	Min	Max	
f_{MAX}	CLKAB or CLKBA Frequency(2)		150	—	—	—	MHz
t_{PD}	Propagation Delay Ax to Bx or Bx to Ax		1.5	4.6	1.5	5.2	ns
	Propagation Delay LEBA to Ax, LEAB to Bx		1.5	5.3	1.5	6.0	
	Propagation Delay CLKBA to Ax, CLKAB to Bx		1.5	5.3	1.5	6.0	
t_{EN}	Output Enable Time $\overline{OEBA}$ to Ax, OEAB to Bx		1.5	5.6	1.5	6.0	ns
t_{DIS}	Output Disable Time(2) $\overline{OEBA}$ to Ax, OEAB to Bx		1.5	5.8	1.5	6.5	ns
t_{SU}	Setup Time HIGH or LOW Ax to CLKAB, Bx to CLKBA		3.0	—	3.0	—	ns
t_H	Hold Time HIGH or LOW Ax to CLKAB, Bx to CLKBA		0	—	0	—	ns
t_{SU}	Setup Time HIGH or Low	Clock LOW	3.0	—	3.0	—	ns
	Ax to LEAB Bx to LEBA	Clock HIGH	2.0	—	2.0	—	ns
t_H	Hold Time HIGH or LOW Ax to LEAB, Bx to LEBA		1.5	—	1.5	—	ns
t_W	Pulse Width(2)		3.0	—	3.0	—	ns
$t_{SK(O)}$	Output Skew(3)		—	0.5	—	0.5	ns

Notes:
1. See test circuit and waveforms. Minimum Limits are guaranteed but not tested on Propagation Delays.
2. Guaranteed by characterization.
3. Skew between any two outputs, of the same package, switching in the same direction. This parameter is guaranteed by characterization but not production tested.

TEST CIRCUIT AND WAVEFORMS

Figure 3. Test Circuit



SWITCH POSITION

Test	Switch
Open Drain Disable LOW Enable LOW	6V
Disable HIGH Enable HIGH	GND
All Other Inputs	Open

DEFINITIONS:
C_L = Load capacitance: includes jig and probe capacitance.
R_T = Termination resistance: should be equal to Z_{OUT} of the Pulse Generator.

Figure 4. Setup, Hold, and Release Timing

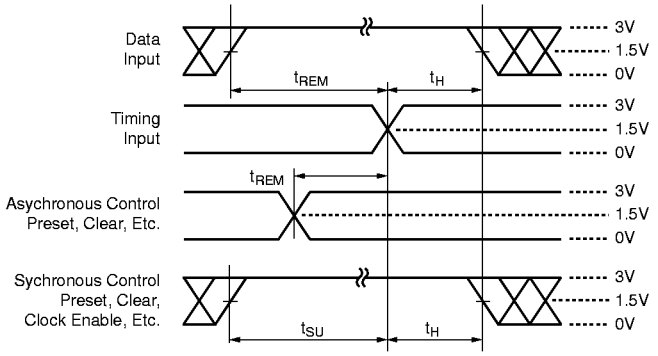
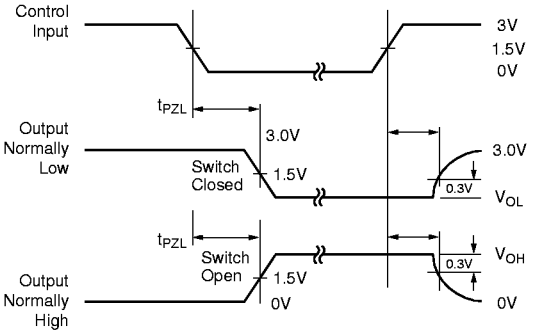


Figure 5. Enable and Disable Timing



Notes:
1. Input Control Enable = LOW and Input Control Disable = HIGH.
2. Pulse Generator for All Pulses: Rate ≤ 1.0MHz; $Z_{OUT} \leq 50\Omega$; t_F, $t_R \leq 2.5$ns.

Figure 6. Pulse Width

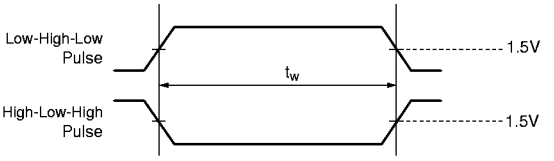
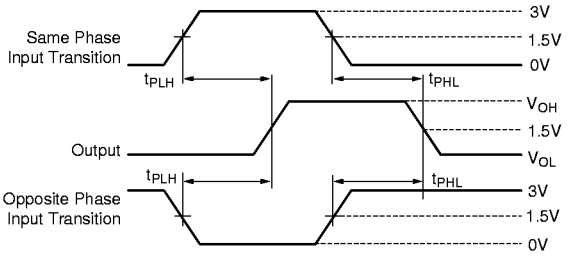
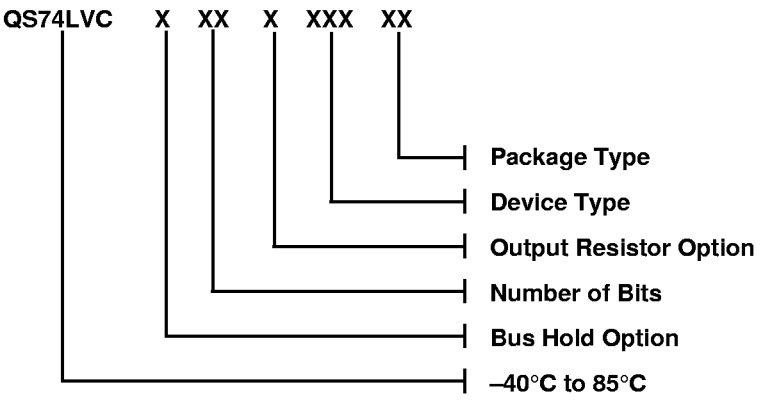


Figure 7. Propagation Delay



ORDERING INFORMATION



Bus Hold Option:
H – with Bus Hold

Number of Bits:
16 – 18-Bit

Output Resistor Option:
Blank – No Output Resistor

Device Type:
501

Package Type:
PV – SSOP, 300 mil
PA – TSSOP, 240 mil